

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Steven R. Lange

Attorney Docket No.: KLA1P027X1

Application No.: 10/072,469

Examiner: Not yet assigned

Filed: February 6, 2002

Group: 2873

Title: MULTI-DETECTOR MICROSCOPIC
INSPECTION SYSTEM

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail to: Commissioner for Patents, Washington, DC 20231 on May 17, 2002.

Signed:

Tara Hayden

AMENDMENT TRANSMITTAL

Commissioner for Patents
Washington, DC 20231

Sir:

Transmitted herewith is an Amendment in the above-identified application.

The fee has been calculated as shown below.

	Claims After Amendment		Highest Previously Paid For	Present Extra	Small Entity Rate Fee	Large Entity Rate Fee
Total Claims	37	MINUS	37	0	x 9 =	x 18 =
Independent Claims	5	MINUS	5	0	x 42 =	x 84 =
Multiple Dependent Claim Present and Fee Not Previously Paid					\$140.00	\$280.00
Total					\$	\$

- ☐ Applicant(s) hereby petition for a _____ month extension(s) of time to respond to the aforementioned Office Action.
- ☒ Applicant(s) believe that no (additional) Extension of Time is required; however, if it is determined that such an extension is required, Applicant(s) hereby petition that such an extension be granted and authorize the Commissioner to charge the required fees for an Extension of Time under 37 CFR 1.136 to Deposit Account No. 500388.
- ☐ Enclosed is our Check No. _____ in the amount of \$ _____ to cover the additional claim fee and/or extension of time fees.
- ☒ Please charge the required fees, or any additional fees required to facilitate filing the enclosed response, to Deposit Account No. 500388 (Order No. KLA1P027X1).

Respectfully submitted,
BEYER WEAVER & THOMAS, LLP
Phillip P. Lee
Reg. No. 46,866P.O. Box 778
Berkeley, CA 94704-0778RECEIVED
JUN 10 2002
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Signed: 

Tara Hayden

PRELIMINARY AMENDMENTAssistant Commissioner for Patents
Washington, D.C. 20231

Dear Sir or Madame:

For this preliminary amendment, which is intended to precede the first office action, please enter the following amendments and remarks:

IN THE SPECIFICATIONPlease AMEND the specification as follows:

At page 1, delete the paragraph within the CROSS-REFERENCE TO RELATED APPLICATIONS section and replace the deleted paragraph with the following replacement paragraph:

This application is a continuation-in-part of U.S. patent application No. 09/602,920, now U.S. Patent No. 6,362,923 B1, filed June 23, 2000, entitled "Lens For Microscopic Inspection," which claims priority of U.S. provisional patent application No. 60/188,309, filed March 10, 2000, entitled "IMPROVED LENS FOR MICROSCOPIC INSPECTION," which is hereby incorporated by reference.

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